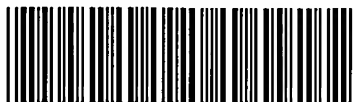


**Search Notes**

Application/Control No.

10/693,640

Examiner

Quynh H. Nguyen

Applicant(s)/Patent under  
Reexamination

FINK ET AL.

Art Unit

2642

**SEARCHED**

Class	Subclass	Date	Examiner
379	93.17 93.23 265.01 265.02 265.03	6/15/2005	QN
379	265.11 309	6/15/2005	QN

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
searched: east	6/15/2005	QN